PR3BMF52NSZF

I⊤(rms)≦1.2A, Non-Zero Cross type DIP 8pin Triac output SSR



Description

PR3BMF52NSZF Solid State Relay (SSR) is an integration of an infrared emitting diode (IRED), a Phototriac Detector and a main output Triac. This device is ideally suited for controlling high voltage AC loads with solid state reliability while providing 4kV isolation (V_{iso} (rms)) from input to output.

Agency approvals/Compliance

- 1. Approved by UL file No.E94758 (as model No.**R3BMF5**)
- 2. Approved by CSA file No.LR63705 (as model No.**R3BMF5**)
- 3. Optionary approved by VDE (DIN EN 60747-5-5), file No.40008898 (as model No.**R3BMF5**)
- 4. Package resin : UL flammability grade (94V-0)

Features

- 1. Output current, $I_T(rms) \le 1.2A$
- 2. Non-zero crossing functionary
- 3.8 pin DIP package
- 4. High repetitive peak off-state voltage (V_{DRM} : 600V)
- 5. Minimum trigger current, IFT : MAX. 5mA
- 6. Superior noise immunity (dV/dt : MIN. $100V/\mu s$)
- 7. Response time, t_{on} : MAX. 100 μ s
- 8. High isolation voltage between input and output $(V_{iso}(rms): 4kV)$
- 9. RoHS directive compliant

■Applications

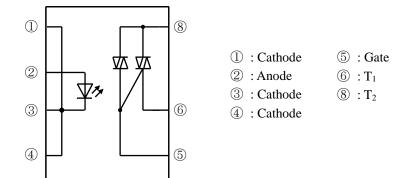
- 1. Isolated interface between high voltage AC devices and lower voltage DC control circuitry.
- 2. Switching motors, fans, heaters, solenoids, and valves.
- 3. Phase or power control in applications such as lighting and temperature control equipment.

Notice The content of data sheet is subject to change without prior notice.

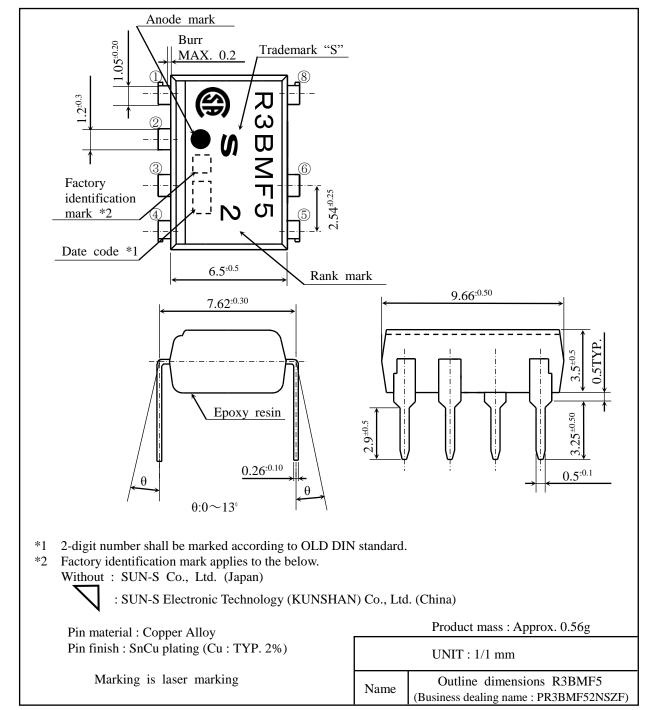
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■Pin-Number and internal connection diagram



■Outline



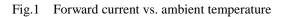
■Absolute maximum ratings

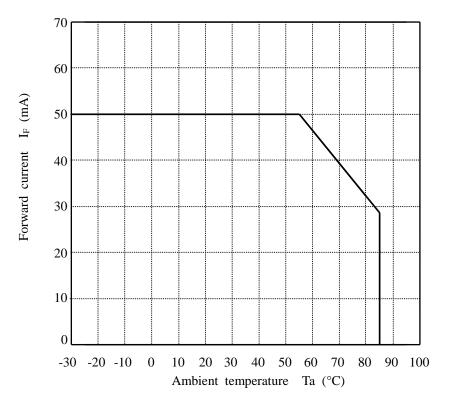
	5			Ta=25°C
	Parameter	Symbol	Rating	Unit
Innut	Forward current *1	$I_{\rm F}$	50	mA
Input	Reverse voltage	V _R	6	V
	RMS on-state current *1	I _T (rms)	1.2	А
Output	Peak one cycle surge current	Isurge	12 (50Hz sine wave)	А
	Repetitive peak off-state voltage	V _{DRM}	600	V
	Isolation voltage *2	Viso(rms)	4.0	kV
	Operating temperature	Topr	-30 to +85	°C
Storage temperature		Tstg	-40 to +125	°C
	Soldering temperature	Tsol	270 (10s)	°C

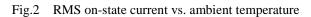
*1 The derating factors of absolute maximum ratings due to ambient temperature are shown in Fig.1, 2.
*2 AC 1min, 40 to 60%RH, f=60Hz *1

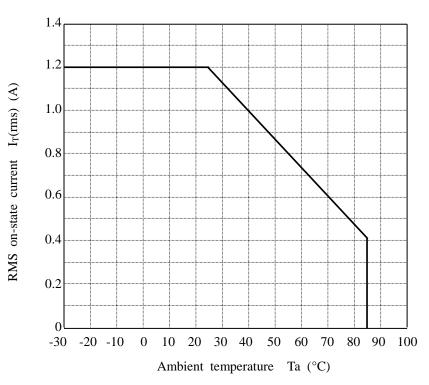
■Electrical Characteristics

						Т	a=25°C
	Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Invest	Forward voltage	V _F	I _F =20mA	-	1.2	1.4	V
Input	Reverse current	IR	V _R =3V	-	-	10	μΑ
	Repetitive peak off-state current	I _{DRM}	V _D =V _{DRM}	-	-	100	μΑ
Output	On-state voltage	VT	I _T =1.2A	-	-	2.5	V
Output	Holding current	I _H	V _D =6V	-	-	25	mA
	Critical rate of rise of off-state voltage	dv/dt	$V_D=1/\sqrt{2} \cdot V_{DRM}$	100	-	-	V/µs
	Minimum trigger current	I _{FT}	$V_D=6V, R_L=100\Omega$	-	-	5	mA
Transfer	Isolation resistance	R _{ISO}	DC500V 40 to 60%RH	5×10 ¹⁰	1011	-	Ω
charac- teristics	Turn on time	t _{ON}	$V_D=6V, R_L=100\Omega, I_F=10mA$	-	-	100	μs









*1 Mounting conditions

No heat sink, Paper phenol board : $100mm \times 1.6mm$ All pins should be installed in the print board with soldering. Whole solder landing dimensions : $140mm^2$

■Supplement

- •Isolation voltage shall be measured in the following method.
- (1) Short between pins 1 to 4 on the primary side and between pins 5 to 8 on the secondary side.
- (2) The dielectric withstanding tester with zero-cross circuit shall be used.
- (3) The wave form of applied voltage shall be a sine wave.
 - (It is recommended that the isolation voltage be measured in insulation oil.)
- •This Model is approved by UL and CSA.

Approved Model No. : R3BMF5

UL file No. : E94758

CSA file No. : LR63705

CSA approved mark "

" and rating shall be indicated on minimum unit package.

• This product is not designed against irradiation.

This product incorporates non-coherent light emitting diode.

This product is assembled with electrical input and output.

•ODS materials

This product shall not contain the following materials.

Also, the following materials shall not be used in the production process for this product.

Materials for ODS : CFC_S, Halon, Carbon tetrachloride, 1.1.1-Trichloroethane (Methyl chloroform)

- •Specified brominated flame retardants (PBB and PBDE) are not used in this device at all.
- •Compliance with each regulation
 - 1) The RoHS directive (2002/95/EC)

This product complies with the RoHS directive (2002/95/EC).

Object substances: mercury, lead (except for lead in high melting temperature type solders*1 and glass of

electronic components), cadmium, hexavalent chromium, polybrominated biphenyls (PBB) and polybrominated diphenyl ethers (PBDE)

*1 : i.e. tin-lead solder alloys containing more than 85% lead

2) Content of six substances specified in Management Methods for Control of Pollution Caused by Electronic

Information Products Regulation (Chinese: 电子信息产品污染控制管理办法).

	Toxic and hazardous substances						
Category	Lead (Pb)	Mercury (Hg)	Cadmium (Cd)	Hexavalent chromium (Cr ⁶⁺)	Polybrominated biphenyls (PBB)	Polybrominated diphenyl ethers (PBDE)	
Solid State Relay	*	1	1	~	1	1	

✓ : indicates that the content of the toxic and hazardous substance in all the homogeneous materials of the part is below the concentration limit requirement as described in SJ/T 11363-2006 standard.

* : indicates that the content of the toxic and hazardous substance in at least one homogeneous material of the part exceeds the concentration limit requirement as described in SJ/T 11363-2006 standard.

■Notes

- •Circuit designing
 - (1) The LED used in the solid state relay coupler generally decreases the light emission power by operation. In case of long operation time, please decide I_F value so that I_F is twice or more of the Maximum value of the Minimum triggering current at circuit design with considering the decreases of the light emission power of the LED. (50%/5years)
 - (2) This device doesn't have built-in snubber circuit.

To avoid the false operation and protect SSR, please locate the appropriate snubber circuit between output pins base on the load. (Recommendable values : $Rs=47\Omega$, $Cs=0.022\mu$ F)

Particularly, in case the device is used for the load such as solenoid valves and motors, false operation may happen in off-state due to rapid change of voltage at output pins caused by the phase difference of load current. So please be sure to locate the snubber circuit (Rs= 47Ω , Cs= 0.022μ F) and make sure the device works properly in actual conditions.

In addition, the values of snubber circuit may have to be changed if necessary after tested in actual conditions. (3) Input current (I_F) at off-state shall be set 0.1mA or less.

- (4) In case that pulse drive is carried out, the pulse width of input signal should be 1ms or more.
- (5) If the voltage exceeding the repetitive peak off-state voltage (V_{DRM}) in the absolute maximum ratings is applied to the phototriac, it may cause not only faulty operation but breakdown.

Make sure that the surge voltage exceeding V_{DRM} shall not be applied by using the varistor, CR.

- •Using method
- As to this product, all pin shall be used by soldering on the print wiring board. (Socket and others shall not be used.) •Cleaning

Please consider following items when cleaning.

- (1) Solvent cleaning : Solvent temperature 45°C or less, Immersion for 3 min or less
- (2) Ultrasonic cleaning : The effect to device by ultrasonic cleaning differs by cleaning bath size, ultrasonic power output, cleaning time, PCB size or device mounting condition etc.

Please test it in actual using condition and confirm that any defect doesn't occur before starting the ultrasonic cleaning.

(3) Applicable solvent : Ethyl alcohol, Methyl alcohol, Isopropyl alcohol

In case the other solvent is used, there are cases that the packaging resin is eroded.

Please use the other solvent after thorough confirmation is performed in actual using condition.

•Precautions for Soldering

- (1) In case of flow soldering (Avoid immersing the resin part in the solder.)
 - It is recommended that flow soldering be carried out at 270°C or less and within 10s
 - (Pre-heating:100 to 150°C, 30 to 80s) : Within 2 times
- (2) In case of hand soldering

It is recommended that hand soldering be carried out at 400°C or less and within 3s. : Within 2 times

(3) Other precaution

Depending on equipment and soldering conditions (temperature, Using solder etc.), the effect to the device and the PCB is different.

Please confirm that there is no problem on the actual use conditions in advance.

•Country of origin of this product is Japan or China.

Package specification

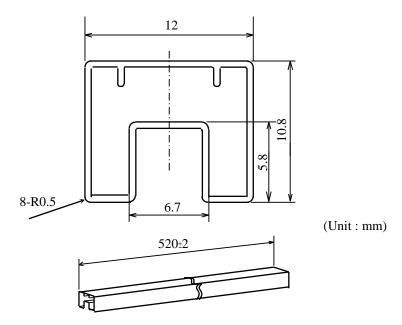
•Package materials

No.	Name	Materials	Purposes
1	Sleeve	HIPS or ABS with preventing static electricity	Products packaged
2	Stopper	Styrene-Elastomer	Products fixed
3	Packing case	Corrugated cardboard	Sleeve packaged
4	Kraft tape	Paper	Lid of packaged case fixed
5	Label	Paper	Model No. (Business dealing name), lot No. quantity, country of origin, Company name and inspection date specified

•Package method

- (1) MAX. 50pcs. of products shall be packaged in a sleeve ① and both of sleeve edges shall be fixed by stoppers ②.
- (2) MAX. 20 sleeves above shall be packaged in a packing case 3 and pack a sheet of cushion at one side.
- (3) The label (5) shall be put on the side of the packing case.
- (4) Case shall be closed with the lid and enclosed with Kraft tape 4.

•Sleeve package ① outline dimensions

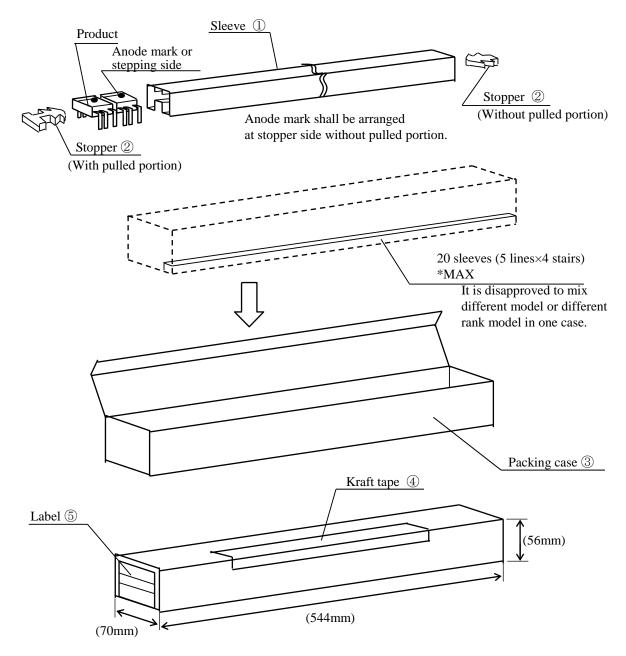


Note 1) Thickness: 0.5±0.2mm

- 2) Process with applying antistatic treatment.
- 3) Unless otherwise specified tolerances shall be ± 0.5 mm.
 - (However except for deformation due to the rubber stopper in sleeve.)



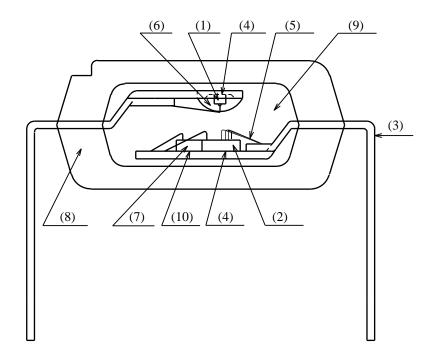
• Packing outer case outline dimensions



Regular packing mass : Approx.970g () : Reference dimensions



PR3BMF52NSZF Construction drawing (Reference)



No.	PARTS	MATERIAL
(1)	Infrared Light Emitting Diode Chip	Gallium-Arsenic
(2)	Phototriac chip	Silicon
(3)	Lead Frame	Copper Alloy (Outer plating: Sn2Cu plating)
(4)	Paste	Silver Epoxy
(5)	Wire	Gold
(6)	Transparent Compound	Silicone
(7)	Triac chip	Silicon
(8)	Opaque Compound	Epoxy (UL flammability grade:94V-0)
(9)	Semitransparent Compound	Ероху
(10)	Solder	High melting temperature type solder

(Attachment-1-1)

- •This specification shall be applied to Solid State Relay (SSR), Model No. R3BMF5 series as an option.
- •Applicable Models (Business dealing name) PR3BMF52YSZF
- •The relevant models are the models Approved by VDE according to DIN EN 60747-5-5 VDE approved No. : 40008898

Approved Model No. : R3BMF5

- Operating isolation voltage V_{IORM (Peak)}: 890V
- Transient voltage (Peak): 7100V
- Pollution : 2
- Clearances distance (Between input and output) : 6.4mm (MIN.)
- Creepage distance (Between input and output) : 6.4mm (MIN.)
- Isolation thickness between input and output : 0.15mm (MIN.)

- Tracking-proof : CTI 175
- Safety limit values

Current (Isi) : 200mA (Diode side) Power (Psi) : 3600mW (Triac side)

Temperature (Tsi) : 150°C

In order to keep safety electric isolation of photocoupler, please set the protective circuit to keep within safety limit values when the actual application equipment troubled.

Indication of VDE approval "

" is printed on minimum unit package.

•Outline Refer to the attachment-1-2.

•Isolation specification according to EN 60747-5-5

Parameter		Symbol	Condition	Rating	Unit	Remark
Class of environmental test		-	-	30/100/21	-	
Pollution		-	-	2	-	
Maximum operating isolation voltage		VIORM(PEAK)	-	890	V	
Par	tial discharge test voltage (Between input and output)					
	Diagram 1	V _{m(PEAK)}	t _m =10s, qc<5pC	1340	V	Refer to the Diagram 1, 2 (Attachement-1-3)
	Diagram 2		t _{st1} =1s, qc<5pC	1670	V	
Ma	Maximum over-voltage		t _{ini} =60s	7100	V	
Saf	ety maximum ratings					
	1) Case temperature	Tsi	IF=0, PC=0	150	°C	Refer to the Fig. 3, 4
	2) Input current	Isi	Pc=0	200	mA	(Attachement-1-3)
	3) Electric power (Output or Total power dissipation)	Psi	-	3600	mW	
Isolation resistance (Test voltage between input and output ; DC500V)		R _{ISO}	T _{amb} =Tsi	MIN. 10 ⁹	Ω	
			T _{amb} =Topr (MAX)	MIN. 10 ¹¹		
			Tamb=25°C	MIN. 10 ¹²		

•Precautions in performing isolation test

1) Partial discharge test methods shall be the ones according to the specifications of EN 60747-5-5.

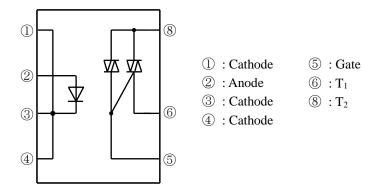
2) Please don't carry out isolation test (Viso) over $V_{ini,a}$.

This product deteriorates isolation characteristics by partial discharge due to applying high voltage (ex. $V_{ini,a}$). And there is possibility that partial discharge occurs in operating isolation voltage (V_{IORM}).

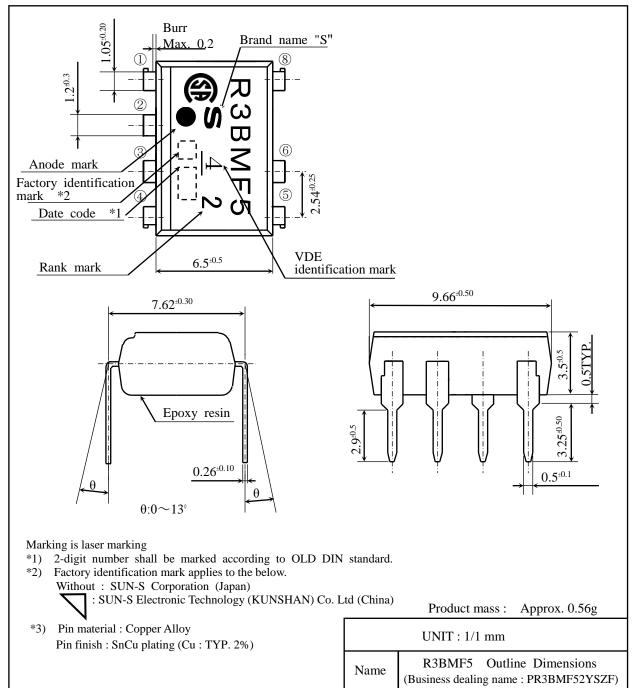


(Attachment-1-2)

•Pin-Number and internal connection diagram



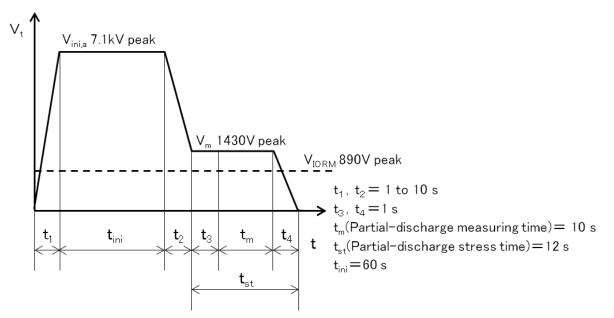
•Outline



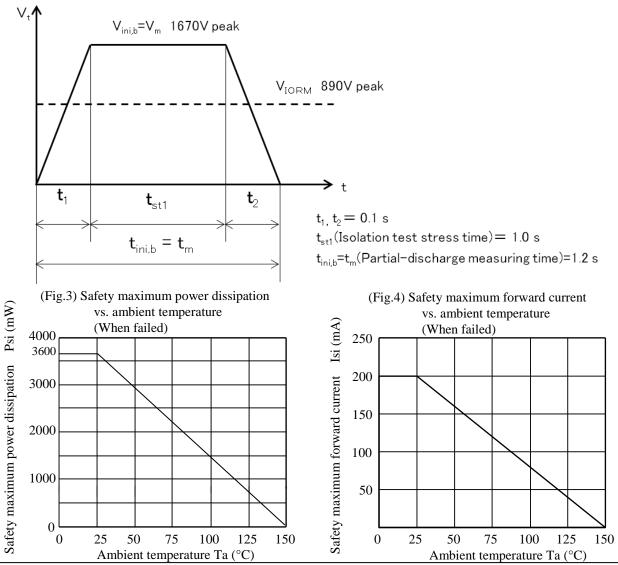


(Attachment-1-3)

Method of Diagram 1: Breakdown test (Apply to type test and sampling test)



Method of Diagram 2: Non breakdown test (Apply to all device test)



Sheet No.: OP14010EN

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- --- Personal computers
- --- Office automation equipment
- --- Telecommunication equipment [terminal]
- --- Test and measurement equipment
- --- Industrial control
- --- Audio visual equipment
- --- Consumer electronics

(ii) Measures such as fail-safe function and redundant design should be taken to ensure reliability and safety when SHARP devices are used for or in connection with equipment that requires higher reliability such as:

- --- Transportation control and safety equipment (i.e., aircraft, trains, automobiles, etc.)
- --- Traffic signals
- --- Gas leakage sensor breakers
- --- Alarm equipment
- --- Various safety devices, etc.

(iii) SHARP devices shall not be used for or in connection with equipment that requires an extremely high level of reliability and safety such as:

- --- Space applications
- --- Telecommunication equipment [trunk lines]
- --- Nuclear power control equipment
- --- Medical and other life support equipment (e.g., scuba).

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